AMENDMENTS TO THE CLAIMS

This listing of claims will replace all prior versions of claims in the application:

Listing of Claims:

- (Currently Amended) A heat regulating device for regulating a heat flow into and out of an integrated circuit semiconductor body comprising:
- a <u>plurality of</u> thermo-electrical structures that <u>create a uniform temperature</u> gradient across a semiconductor body via heat inducement to and/or dissipation of induces heat to and/or dissipates generated heat away from a portion of an the integrated circuit semiconductor body;

at least one layer of a conductive material in contact with the <u>plurality of</u> thermoelectrical <u>structures</u> for conducting heat flow.

- (Currently Amended) A heat regulating device according to claim 1, <u>each of</u> the thermoelectrical <u>structures</u> is a trough within the body of the layer of the conductive material.
- (Currently Amended) A heat regulating device according to claim 1, further comprising a
 the plurality of the thermo-electrical structures connected to form a spreading assembly.
- (Original) A heat regulating device according to claim 3, the spreading assembly is
 operatively connected to a heat sink.
- (Currently Amended) A heat regulating device according to claim 1, <u>each of</u> the thermoelectrical structure structures is a conductive pathway for heat transfer.
- 6. (Currently Amended) A heat regulating device according to claim 1, <u>each of</u> the thermoelectrical <u>structures</u> has a structure of line patterns selected from a group comprising: maze-shaped structure, helix structure, and a spring structure.

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 (Currently Amended) A heat regulating device for regulating a heat flow of an integrated circuit comprising:

means for inducing heat into a portion of a semiconductor body of the integrated circuit utilizing a plurality of thermo-electric [[structure]] structures; and/or

means for dissipating heat away from a portion of a semiconductor body of the integrated circuit utilizing a plurality of thermo-electric [[structure]] structures;

the heat inducing means and/or heat dissipating means create a uniform temperature gradient across the semiconductor body; and

heat conducting means in contact with the means for inducing heat into or dissipating heat away from the portion of the semiconductor body.

8-22. (Cancelled)

- (Currently Amended) A heat regulating device according to claim 3, with components
 embedded into the spreading assembly to manage the heat flow away from and/or into the
 integrated circuit semiconductor body.
- 24. (Currently Amended) A heat regulating device according to claim 6, each of the thermoelectrical structure having structures has a denser distribution of line patterns towards the center of the structure and a less dense distribution of lines towards the outer limits of the structure.
- (Currently Amended) A heat regulating device according to claim 1, each of the thermoelectrical structures being embedded with measuring devices to measure various physical properties of the <u>integrated circuit</u> semiconductor body.
- 26. (Currently Amended) A heat regulating device according to claim 1, each of the thermoelectrical structures being an external element attached to the surface of the heat regulating device.
- (Previously Presented) A heat regulating device according to claim 1, fabricated from a combination of various layers of silicon carbide and diamond.

 (Withdrawn) A method of reducing the accumulation and concentration of stress in ICs comprising:

providing an integrated circuit with a semiconductor chip having hot spots generated therein with a heat regulating device including:

a thermo-electrical structure for at least one of inducing heat into and dissipating generated heat away from a region of a semiconductor body; and

at least one layer of a conductive material in contact with the thermo-electrical structure for conducting heat flow.

- (Withdrawn) The method of claim 28, further comprising creating a uniform temperature gradient throughout the semiconductor body.
- (Withdrawn) The method of claim 29, the uniform temperature gradient being created by inducing heat into various regions of the semiconductor body.
- 31. (Withdrawn) The method of claim 29, the uniform temperature gradient being created by dissipating heat from the hot spots into the layer of conductive material of the heat regulating device.
- 32. (Currently Amended) A heat regulating device according to claim 1, each of the thermoelectrical structures is a composite composed of a layer having at least one part tailored to a heat-generating characteristic of a portion of the integrated circuit semiconductor body.
- 33. (Previously Presented) A heat regulating device according to claim 1, at least one thermoelectric structure is integrated with the semiconductor body such that the thermo-electrical structure is positioned in a region of the semiconductor body where a hot spot is anticipated.

34. (Previously Presented) A system that facilitates reducing the accumulation and concentration of stress in an integrated circuit, comprising:

means for inducing heat into a region of a semiconductor body of the integrated circuit; means for dissipating generated heat away from a region of a semiconductor body of the integrated circuit; and

means for creating a uniform temperature gradient throughout the integrated circuit based at least in part upon one of the heat dissipation and the heat induction.